Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | AHN, SEUNG KUK | Examiner | LUN-YI LAO | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,301,031	04-1994	Eto et al.	348/792
	В	US-6,084,562	07-2000	Onda, Yasuyuki	345/94
	C	US-6,683,596	01-2004	Ozawa, Tokuro	345/100
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
<u> </u>	0						
	Р						
	Q						
	R						
	s						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.